



Report #: 6R74703

ElectroMagnetic Compatibility Test Report

- FCC 47 CFR Part 15, Subpart B (Verification)
- ICES-003 Issue 4 February 2004
- EN 55022: 1998 + amendment A1: 2000 + amendment A2: 2003
- EN 61000-3-3: 1995 + Amendment A1: 2001
- EN 61000-3-2: 2000

Vigna

Reviewed by:

Signature Daniel Hynes, EMC Specialist

November 1, 2006 Date

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N Nemko	
Nemko Canada Inc.,	
303 River Road, R.R. 5, Ottawa, Ontario, Canada, K1V 1H2	Report No: 6R74703

Declaratory Statements

Model #: 103544 Model Variants #: 103430						
Model Variants #: 103430						
Model Variants #: 103430						
Nanoptix						
Tradamarky						
Serial #: None						
Applicant:						
Nanoptix Inc.						
699 Champlain Street						
Dieppe, New Brunswick, Canada						
EIAIP6						
Manufacturer:						
Nanopux Inc.						
Dienne New Brunswick Canada						
E1A1P6						
Factory:						
Nanoptix Inc.						
699 Champlain Street						
Dieppe, New Brunswick, Canada						
E1A1P6						
New Product						
Droduct Deckground Information						
The test was performed for the following researce						
Product Audit						
Other						
Test Procedure: ANSI C63.4-2003/CISPR22						
Test Location: 303 River Road, R.R. 5. Ottawa, Ontario, Canada, K1V 1H2						
······································						
Limits of Responsibility						
The results included in this test report apply only to the equipment listed within this report as being the Equipment Under Test						
(EUT). Equipment listed as support equipment is not considered to be part of the EUT. In some instances, the EUT may consist of multiple devices in a single enclosure, and will be so indicated in the report						

Measurement Uncertainty

Measurement	Test Specification	Ulab
Conducted disturbance	9kHz – 150kHz	4.0dB
Collucted disturbance	150kHz – 30MHz	3.6dB
	30MHz – 200MHz Horizontal polarization	4.7dB
Pediated disturbance	200MHz – 1000MHz Horizontal polarization	4.7dB
Radiated distuibance	30MHz – 200MHz Vertical polarization	4.9dB
	200MHz – 1000MHz Vertical polarization	4.9dB

Accuracy of Measurement

Measurement uncertainty was calculated using the methods described in CISPR 16-4 Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC measurements and Nemko Canada Inc. procedure EMC/MUC/001 Uncertainty in EMC Measurements.

Lab Environmental Conditions

Ambient Temperature: 15°C to 35°C, Relative Humidity: 30% to 60%, Atmospheric Pressure: 86kPa (860mbar) to 106kPa (1 060mbar)

Measurement Equipment Setup

These are the standard bandwidth and possible detector settings used during emissions testing

9 kHz - 150 kHz	200 Hz bandwidth, Quasi-Peak detector with linear response; Peak detector with log response; Average detector with linear response
150 kHz - 30 MHz	9 kHz bandwidth, Quasi-Peak detector with linear response; Peak detector with log response; Average detector with linear response
30 MHz - 1 GHz	120 kHz bandwidth, Quasi-Peak detector with linear response; Peak detector with log response
1 GHz - 18 GHz	1 MHz bandwidth, Peak detector with log response, Average detector with linear response

Statement of Compliance

	TEST RESULT					
EN 55022: 1998 + amendment A1: 2000 + amendment A2: 2003 Class A	PASS/FAIL/NA					
Radiated Disturbance	PASS					
Conducted Disturbance at Mains Port	PASS					
Conducted Common mode (asymmetric mode) Disturbance at Telecommunication Ports	N/A					
Notes						
 Test Method Used: CISPR 22 System Power: 230VAC/50Hz All tests were performed using measurement apparatus defined in CISPR 16-1. Radiated Emissions were performed on an open area test site within the NSA conforming to the requirements of CISPR16-1. 						
	TEST RESULT					
FCC 47 CFR Part 15, Subpart B for Digital Devices. Class A	PASS/FAIL/NA					
Radiated Disturbance	PASS					
Conducted Disturbance at Mains Port	PASS					
Notes						
 Test Method Used: ANSI C63.4-2003 System Power: 120VAC/60Hz The equipment was tested for conducted emissions from 0.15MHz to 30MHz using a 50 microhenry line impedance stabilization network (L.I.S.N.) as described in ANSI C63.4-2003. Peripheral equipment was also operated through a 50 microhenry L.I.S.N. 						
	TEST RESULT					
ICES-003 Issue 4 February 2004. Class A	PASS/FAIL/NA					
Radiated Disturbance	PASS					
Conducted Disturbance at Mains Port	PASS					
Notes						
 Test Method Used: CISPR 22 System Power: Radiated: 120VAC/60Hz All tests were performed using measurement apparatus defined in CISPR 16-1. Radiated Emissions were performed on an open area test site within the NSA conforming to the requirements of CISPR16-1. 						

Nemko	
Nemko Canada Inc.,	
303 River Road, R.R. 5, Ottawa, Ontario, Canada, K1V 1H2	Report No: 6R74703

Statement of Compliance, continued

	TEST RESULT
EN 61000-3-2: 2000	PASS/FAIL/NA
Class A	PASS
Class B	N/A
Class C	N/A
Class D	N/A
Notes	
- Test Method Used: EN 61000-3-2: 2000	
– System Power: 230VAC/50Hz	
 Refer to EN 61000-3-2: 2000 for classification of equipment. 	
	TEST RESULT
EN 61000-3-3: 1995 + Amendment A1: 2001	PASS/FAIL/NA
Voltage fluctuations and flicker at the supply terminals of the Equipment under test	PASS
Notes	
- Test Method Used: EN 61000-3-3: 1995 + Amendment A1: 2001	
– System Power: 230VAC/50Hz	

Engineering Considerations

Product Modification Required for Compliance

The following modification was installed by Nemko as requested by client to pass radiated disturbance. See picture below:



Justification

Client provided two units for assessment (H/S Kiosk "C" and H/S Kiosk "V" Printer). Both samples were prescanned at 3m in a lined chamber. Advised client that units had a similar emissions footprint. Client then decided to continue testing on H/S Kiosk "C" Printer as the worst-case representative. The two samples have the same electrical hardware. The only difference is the housing.

Deviations from Standard Test Procedure

None

Test Report Revision History					
Issue #	Details of changes made to test report				
-	Original Report Issued				
N/A	N/A				

General Information Regarding the Equipment Under Test (EUT)

Date Received In Laboratory: October 16, 2006

Nemko Identification Number: Item #1

Description & Theory of Operation:

High Speed Kiosk Compact Version Thermal Printer with 80mm roll of paper, right hand side paper loading.

EUT Clock and Operational Frequencies: 12MHz (crystal), 192MHz internal to DSP processor

Exercise/Monitoring method:

Continual Printing Feature. Press paper feed button once prints one ticket, hold for 5 seconds will print continually.

Continual Printing Feature, no errors should occur during testing process, unit will recover if failure occurs.

Software Version: Continual Printing Feature.

Equipment Configuration

Equipment Configuration List							
Item	Description Identification: (MN#, SN#, PN#, Rev.)						
(A)	H/S Kiosk "C" Printer MN# 103544						
(B)	Nanoptix ITE Power Supply	PN# 100600-00	023-00-ROHS, MN	N# GT-21126-	6024		
EUT Po	orts	•					
Item	Description		Indoor/Outdoor	Type (See Leg	end) Qty		
i.	24VDC Input		Indoor	2	1		
ii.	AC Input		Indoor	1	1		
iii.	USB		Indoor	4	1		
iv.	Serial (DB25 to DB9)		Indoor	4	1		
v.	JR11		Indoor	5	1		
Inter-Co	onnection Cables						
Item	Description				Length (m)		
(1)	18AWG Two conductor				0.5		
(2)	Three Conductor Power Cable				1.8		
(3)	USB				2.5		
(4)	DB25 to DB9 Serial Cable 2.5						
(5)	RJ11						
Legend:							
1 = ACP	ower Input/Output, 2 = DC Power Input/Output, 3 = 7	Telecom, $4 = $ Non-te	lecom I/O, 5 = Mainter	nance, 6 = Fiber (Optic		
Configu	aration of the Equipment Under Test (EUT)						
(A) i. (I) (B) iii. iv. v. (2) (3) (4) (5) AC Input							
Notes							
None							

Radiated Disturbance

Test Date:	October	25, 20)06								
Engineer's Name: David Duchesne											
Tested as per: Table Top											
Enclosure Investigation Data											
Test Distance (meters): 10 Location: Dome 1											
EN 55022: 1998 + amendment A1: 2000 + amendment A2: 2003											
Freq. (MHz)	Ant.	Pol. V/H	RCVD Signal (dBµV)	Ant. Factor (dB)	Amp. Gain (dB)	Cable Loss (dB)	Field Strength (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector	Amp.
88.0044	BC1	V	30.5	7.7	N/A	1.5	39.7	40.0	0.3	Q-Peak	N/A
168.0044	BC1	V	25.0	12.5	N/A	2.0	39.4	40.0	0.6	Q-Peak	N/A
184.0044	BC1	V	22.0	13.8	N/A	2.0	37.8	40.0	2.2	Q-Peak	N/A
72.0044	BC1	V	26.0	8.5	N/A	1.3	35.8	40.0	4.2	Q-Peak	N/A
56.0044	BC1	V	26.0	8.7	N/A	1.1	35.8	40.0	4.2	Q-Peak	N/A
120.0044	BC1	V	22.0	10.7	N/A	1.7	34.4	40.0	5.6	Q-Peak	N/A
152.0044	BC1	V	16.2	11.5	N/A	1.8	29.5	40.0	10.5	Q-Peak	N/A
136.0044	BC1	V	15.0	11.8	N/A	1.8	28.6	40.0	11.4	Q-Peak	N/A
FCC 47 C	CFR Part	t 15, S	ubpart B								
Freq. (MHz)	Ant.	Pol. V/H	RCVD Signal (dBµV)	Ant. Factor (dB)	Amp. Gain (dB)	Cable Loss (dB)	Field Strength (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector	Amp.
72.0044	BC1	V	26.0	8.5	N/A	1.3	35.8	39.1	3.3	Q-Peak	N/A
56.0044	BC1	V	26.0	8.7	N/A	1.1	35.8	39.1	3.3	Q-Peak	N/A
88.0044	BC1	V	30.5	7.7	N/A	1.5	39.7	43.5	3.8	Q-Peak	N/A
168.0044	BC1	V	25.0	12.5	N/A	2.0	39.4	43.5	4.1	Q-Peak	N/A
184.0044	BC1	V	22.0	13.8	N/A	2.0	37.8	43.5	5.7	Q-Peak	N/A
120.0044	BC1	V	22.0	10.7	N/A	1.7	34.4	43.5	9.1	Q-Peak	N/A
152.0044	BC1	V	16.2	11.5	N/A	1.8	29.5	43.5	14.0	Q-Peak	N/A
136.0044	BC1	V	15.0	11.8	N/A	1.8	28.6	43.5	14.9	Q-Peak	N/A
Legend: Antenna Legend: BC = Biconical, BL = Bilog, LP = Log-Periodic, Horn = Horn, ED = EMCO Dipole Detector Legend: Q-Peak = 120kHz RBW, Average = 1.0MHz RBW											
Notes											
None											

303 River Road, R.R. 5, Ottawa, Ontario, Canada, K1V 1H2

Radiated Disturbance, continued

Enclosure	Enclosure Investigation Data, continued										
Test Dista	nce (met	ers): 1	0			Loca	ation: Dome	1			
ICES-003	ICES-003 Issue 4 February 2004										
Freq. (MHz)	Ant.	Pol. V/H	RCVD Signal (dBµV)	Ant. Factor (dB)	Amp. Gain (dB)	Cable Loss (dB)	Field Strength (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector	Amp.
88.0044	BC1	V	30.5	7.7	N/A	1.5	39.7	40.0	0.3	Q-Peak	N/A
168.0044	BC1	V	25.0	12.5	N/A	2.0	39.4	40.0	0.6	Q-Peak	N/A
184.0044	BC1	V	22.0	13.8	N/A	2.0	37.8	40.0	2.2	Q-Peak	N/A
72.0044	BC1	V	26.0	8.5	N/A	1.3	35.8	40.0	4.2	Q-Peak	N/A
56.0044	BC1	V	26.0	8.7	N/A	1.1	35.8	40.0	4.2	Q-Peak	N/A
120.0044	BC1	V	22.0	10.7	N/A	1.7	34.4	40.0	5.6	Q-Peak	N/A
Legend: Antenna Lege Detector Lege	nd: BC = B end: Q-Peak	iconical, = 120kH	BL = Bilog, I z RBW, Aver	LP = Log-Per age = 1.0MH	iodic, Horn = Iz RBW	= Horn, ED =	= EMCO Dipole				
Notes											
None											
Deviation	8										
Refer to E	Refer to Engineering Considerations.										
Test Resul	Test Result										
Final Tes	st Resul	t: Pas	S								

CAL Cycle Equipment Manufacturer Model No Asset/Serial No Next Cal						
CALCYCIC	Equipment	Wanutacturer	Widdel No.	Asset/Serial No.	Next Cal.	
1 Year	Receiver	Rohde & Schwarz	ESVS-30	FA001445	July 14/07	
1 Year	Biconical (1) Antenna	EMCO	3109	FA000805	May 03/07	

Note: N/A = Not Applicable, NCR = No Cal Required, COU = CAL On Use



Radiated Disturbance, continued



Conducted Disturbance at Mains Port

Test Date: October 18, 2006

Engineer's Name: David Duchesne

Tested as per: Table Top

Port Investigation Data

Spectral plots for each frequency band can be found at the back of this section.

- All plots were generated with a peak detector.
- Spectral plots have been corrected with cable, LISN, and attenuator losses to show compliance with the average limit.
- Peak measurements with 3dB or less margin of the average limit line have been measured with a test receiver.

Port under test: AC mains input

Results: Refer to plots and tables of this section.

Receiver Results:

120 VAC/00	112							
Conductor	Frequency (MHz)	Detector	Emission Level (dBuV)	LISN Loss (dB)	Cable Loss (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)
Dlass	24,0000	Quasi Peak	46.0	9.87	0.29	56.16	73.0	16.8
Phase	24.0000	Average	31.0	9.87	0.29	41.16	60.0	18.8
Noutral	24 0000	Quasi Peak	45.0	9.98	0.29	55.27	73.0	17.7
neutrai	24.0000	Average	30.0	9.98	0.29	40.27	60.0	19.7
230VAC/50	Hz							
Conductor	Frequency	Detector	Emission Level	LISN Loss	Cable Loss	Result	Limit	Margin
Conductor	(MHz)	Detector	(dBuV)	(dB)	(dB)	(dBuV)	(dBuV)	(dB)
	0.4030	Quasi Peak	35.0	9.89	0.04	44.93	79.0	34.1
		Average	28.2	9.89	0.04	38.13	66.0	27.9
Dhasa	24.0000	Quasi Peak	45.0	9.87	0.29	55.16	73.0	17.8
Fliase		Average	30.0	9.87	0.29	40.16	60.0	19.8
	16.0000	Quasi Peak	36.0	9.82	0.23	46.05	73.0	27.0
		Average	20.3	9.82	0.23	30.35	60.0	29.7
	0.4030	Quasi Peak	34.8	9.87	0.04	44.72	79.0	34.3
		Average	30.6	9.87	0.04	40.52	66.0	25.5
Noutral	24 0000	Quasi Peak	43.0	9.98	0.29	53.27	73.0	19.7
Incutat	24.0000	Average	26.0	9.98	0.29	36.27	60.0	23.7
	16 0000	Quasi Peak	37.0	9.87	0.23	47.10	73.0	25.9
	10.0000	Average	22.0	9.87	0.23	32.10	60.0	27.9
Notes								
None								
Deviations								

Deviations

Refer to Engineering Considerations.

Test Result

Final Test Result: Pass

Conducted Disturbance at Mains, continued

Test Equipment Used					
CAL Cycle	Equipment	Manufacturer	Model No.	Asset/Serial No.	Next Cal.
1 Year	LISN	Rohde & Schwarz	ENV216	FA002023	Aug. 28/07
1 Year	Spectrum Analyzer	Hewlett-Packard	8566B	FA001309	May 16/07
1 Year	Spectrum Analyzer Display	Hewlett-Packard	85662A	FA001309	May 16/07
1 Year	International Power Supply	California Inst.	3001i	FA001021	Jan. 11/07
1 Year	50 Coax cable	HUBER + SUHNER	None	FA002021	Sept. 08/07
1 Year	50 Coax cable	WFU	None	FA002028	Oct. 02/07

Note: N/A = Not Applicable, NCR = No Cal Required, COU = CAL On Use Setup Photos













Nemko	
Nemko Canada Inc.,	
303 River Road, R.R. 5, Ottawa, Ontario, Canada, K1V 1H2	Report No: 6R74703

Harmonic Current

Test Date:	October 25,	2006

Engineer's Name: David Duchesne

Port Investigation Data

Port under test: AC mains input

Results: Refer to California Instruments CTS – V3.0 data at end of section.

Notes

None

Deviations

Refer to Engineering Considerations.

Test Result

Final Test Result: Pass

Test Equipment Used						
CAL Cycle	Equipment	Manufacturer	Model No.	Asset/Serial No.	Next Cal.	
1 Year	Waveform Analyzer	California Instruments	PACS-1	FA001239	March 21/07	
1 Year	Power Source	California Instruments	5001ix	FA001238	March 21/07	

Note: N/A = Not Applicable, NCR = No Cal Required, COU = CAL On Use



Harmonic Current, continued

Setup Photos



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Harmonic Current, continued



303 River Road, R.R. 5, Ottawa, Ontario, Canada, K1V 1H2

Harmonic Current, continued

California Instruments CTS – V3.0 Data, continued						
Current Test Result Su	Current Test Result Summary (Run time)					
Test category: Class A Stea Test date: 10/25/06 Test duration (min): 2	ady State (European limit Start time: 3:00: Data file name:	s) 29 PM H-000225.cts_data	Test Margin: 100 End time: 3:02:40	PM		
Test Result: Pass	Source	qualification: No	rmal			
Highest parameter values of V_RMS (Volts): I_Peak (Amps): I_Fund (Amps): Power (Watts):	luring test: 229.97 3.261 0.501 50	Frequency (Hz): I_RMS (Amps): Crest Factor: Power Factor:	50.00 0.474 8.351 0.468			
Harm# Har 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 30 31 32 33 24	$\begin{array}{c} \text{rmonics} \\ 0.074 \\ 0.379 \\ 0.064 \\ 0.334 \\ 0.070 \\ 0.273 \\ 0.040 \\ 0.201 \\ 0.048 \\ 0.137 \\ 0.042 \\ 0.094 \\ 0.033 \\ 0.042 \\ 0.094 \\ 0.033 \\ 0.068 \\ 0.029 \\ 0.044 \\ 0.025 \\ 0.038 \\ 0.023 \\ 0.044 \\ 0.019 \\ 0.038 \\ 0.018 \\ 0.025 \\ 0.018 \\ 0.025 \\ 0.016 \\ 0.019 \\ 0.018 \\ 0.021 \\ 0.018 \\ 0.021 \\ 0.014 \\ 0.019 \\ 0.013 \\ 0.017 \\ 0.014 \end{array}$	Limit % of L 1.080 2.300 14 0.430 14 1.140 22 0.300 2 0.770 3 0.230 17 0.400 55 0.184 22 0.330 44 0.153 22 0.210 44 0.153 22 0.210 44 0.131 22 0.150 44 0.115 22 0.132 33 0.102 22 0.118 33 0.092 22 0.107 44 0.084 22 0.098 33 0.077 22 0.098 32 0.071 22 0.098 32 0.071 22 0.098 22 0.071 22 0.073 22 0.066 22 0.073 22 0.068 22 0.054 22	imit S 6.88 6.47 4.94 9.29 3.21 5.51 7.60 0.31 6.26 1.63 7.34 4.85 4.91 5.55 5.28 3.34 4.97 2.25 4.91 1.35 3.29 8.71 3.11 7.42 1.84 3.09 6.64 7.07 3.05 6.40 2.95 5.51 5.45	tatus Pass Pass Pass Pass Pass Pass Pass Pa		
34 35 36 37 38 39 40	0.014 0.017 0.013 0.016 0.015 0.015 0.013	0.054 2 0.064 2 0.051 2 0.061 2 0.048 3 0.058 2 0.046 2	5.43 6.79 6.22 7.13 1.45 6.77 8.46	Pass Pass Pass Pass Pass Pass Pass		

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Harmonic Current, continued

California Instruments CTS – V3.0 Data, continued				
Voltage Source Verific	cation Data (Run tir	ne)		
Test category: Class A Ster Test date: 10/25/06 Test duration (min): 2	ady State (European lin Start time: 3:0 Data file name	nits) 0:29 PM e: H-000225.cts_data	Test Margin: 100 End time: 3:02:40 PM	
Test Result: Pass	Source	ce qualification: Norr	nal	
Highest parameter values of Voltage (Vrms): I_Peak (Amps): I_Fund (Amps):	luring test: 229.97 3.261 0.501	Frequency (Hz): I_RMS (Amps): Crest Factor:	50.00 0.474 8.351	
Power (Watts):	50	Power Factor:	0.468	
Harm# Harmonics V-r 2 0.1 3 0.4 4 0.0 5 0.0 6 0.1 7 0.0 8 0.0 9 0.0 10 0.0 11 0.0 12 0.0	Limit V-rms 32 0.460 03 2.070 58 0.460 65 0.920 16 0.460 64 0.690 39 0.460 44 0.460 67 0.230 28 0.230 39 0.230	% of Limit 28.75 19.47 12.65 7.11 25.17 9.22 8.38 9.66 6.42 29.33 12.39 16 90	Status OK OK OK OK OK OK OK OK OK	
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	22 0.230 31 0.230 22 0.230 26 0.230 24 0.230 28 0.230 22 0.230	9.64 13.60 9.62 11.44 10.31 12.26 9.57	OK OK OK OK OK	
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	28 0.230 28 0.230 17 0.230 23 0.230 17 0.230 22 0.230 18 0.230 17 0.230 16 0.230	12.36 7.53 10.18 7.56 9.51 7.90 7.60 6.88	OK OK OK OK OK OK OK	
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	8.96 6.90 7.33 7.18 8.65 7.91 7.90 7.84 8.24 6.62 7.20 7.95	OK OK OK OK OK OK OK OK OK OK	

N Nemko	
Nemko Canada Inc.,	
303 River Road, R.R. 5, Ottawa, Ontario, Canada, K1V 1H2	Report No: 6R74703

Voltage Fluctuation

Test Date: October 25, 2006
Engineer's Name: David Duchesne
Port Investigation Data
Port under test: AC mains input
Results: Refer to California Instruments CTS – V3.0 data at end of section.
Notes
None
Deviations
Refer to Engineering Considerations.
Test Result
Final Test Result: Pass

Test Equipment Used						
CAL Cycle	Equipment	Manufacturer	Model No.	Asset/Serial No.	Next Cal.	
1 Year	Waveform Analyzer	California Instruments	PACS-1	FA001239	March 21/07	
1 Year	Power Source	California Instruments	5001ix	FA001238	March 21/07	

Note: N/A = Not Applicable, NCR = No Cal Required, COU = CAL On Use



Voltage Fluctuation, continued

Setup Photos



Voltage Fluctuation, continued

California Instruments CTS – V3.0 Data	
Flicker Test Summary per EN/IEC61000-3-3 (Run time)	
EUT: PrinterTested by: David DTest category: All parameters (European limits)Test Margin: 100Test date: 10/25/06Start time: 3:09:11 PMEnd time: 3:19:24 PMTest duration (min): 10Data file name: F-000226.cts_dataComment:Customer: Nanoptic	
Test Result: Pass Status: Test Completed	
Pst _i and limit line	European Limits
1.00	
0.75	
ឆ្កី 0.50	
0.25	
0.00	
	15:19:22
	4
<u>Time is too short for Plt plot</u>	
Parameter values recorded during the test:	
Vrms at the end of test (Volt): 230.15 Highest dt (%): 0.00 Time (mS) > dt: 0.0 Highest dc (%): 0.00 Highest dmax (%): 0.00 Highest Pst (10 min. period): 0.001 Highest Plt (2 hr. period): 0.001	Test limit (%): 3.30 Pass Test limit (mS): 500.0 Pass Test limit (%): 3.30 Pass Test limit (%): 4.00 Pass Test limit: 1.000 Pass Test limit: 0.650 Pass